
HP 84125 Series Microwave EMI Measurement Systems

Product Overview

HP 84125A - 1 to 18 GHz
HP 84125B - 1 to 26.5 GHz
HP 84125C - 1 to 40 GHz

Test Electromagnetic Emissions from 1 to 40 GHz

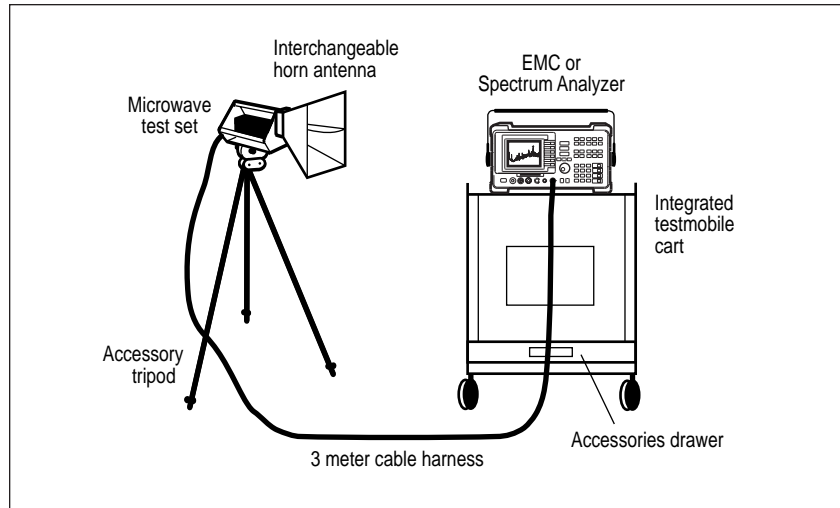


HP 84125 Series Test Systems

Three system configurations allow you to perform electromagnetic interference (EMI) compliance tests on product emissions above 1 GHz. The HP 84125A, B and C microwave EMI test systems cover the 1 to 18 GHz, 1 to 26.5 GHz and 1 to 40 GHz frequency ranges, respectively. System features include:

- **Field-strength measurement calibration**
- **High measurement sensitivity**
- **Mobile configuration**
- **Easy-to-use test interface**
- **General purpose signal analysis capability from 9 kHz**

Test Products to U.S. and European EMI Standards from 1 to 40 GHz

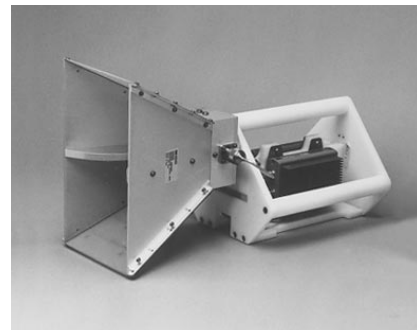


HP 84125 Series Test System

The HP 84125A, B and C microwave EMI measurement systems are designed to test electromagnetic emissions from intentional and unintentional radiators over frequencies from 1 to 40 GHz. Each system is fully integrated and calibrated for testing products to rigorous FCC regulations and proposed European EMI standards above 1 GHz. Microwave EMI regulations cover a wide range of wireless network products including cordless telephones, pagers, security monitors and spread-spectrum transceivers. Equipment manufacturers, EMC test laboratories and regulatory authorities will find the HP 84125 series microwave test systems a valuable addition to their existing EMI test capability. HP 84125 series systems include a microwave EMC analyzer or spectrum analyzer and acces-

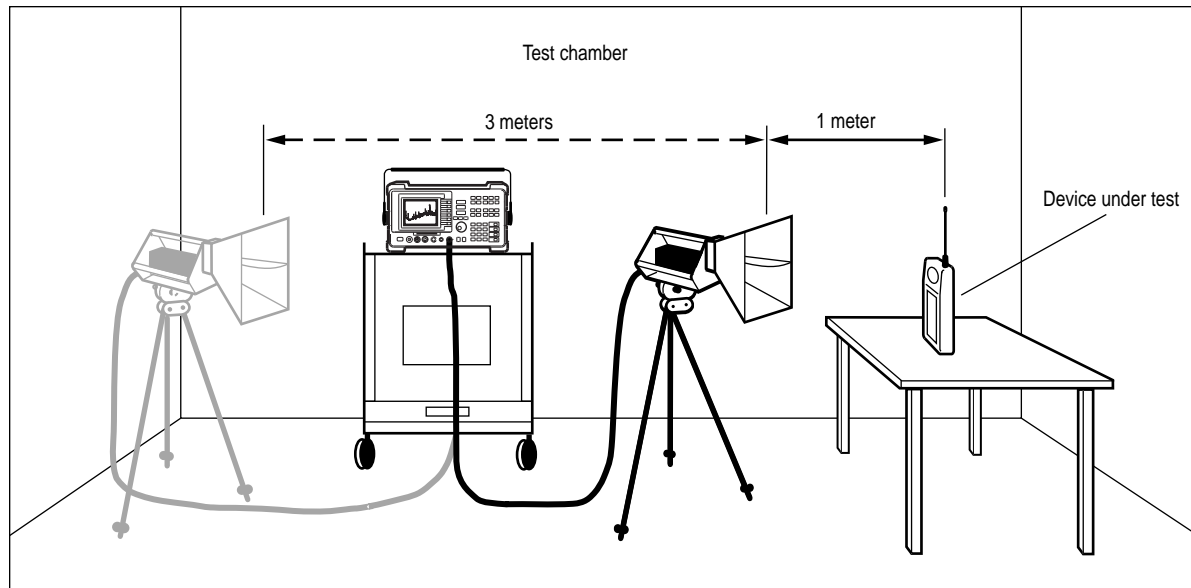
sories mounted on an instrument cart. The cart-mounted equipment is connected to a microwave test set with a 3 meter low-loss RF cable assembly maximizing system sensitivity. The functionality of the HP 8593EM or 8564E analyzers and the microwave test set is combined using a system down-loadable program (DLP). The system DLP provides softkeys on the analyzer display allowing easy setup of measurement parameters. The displayed data is corrected for antenna, cable and filter losses and amplifier gains allowing direct viewing of emission field strengths in dBuV/m. In addition, the HP 8593EM EMC analyzer supplied with HP 84125A and B systems can perform general purpose signal analysis and EMI precompliance tests starting from 9 kHz. The HP 8564E microwave spectrum analyzer supplied with the HP 84125C can perform general purpose signal analysis starting from 100 Hz.

The system test set is designed for tripod or antenna mast mounting or for handheld use for locating worst-case product emissions. A separate, non-metallic tripod accessory is available (HP 11968C). Horn antennas can be interchanged in the HP 84125B and C systems for full frequency coverage from 18 to 26.5 GHz and 26.5 to 40 GHz. In addition, each system includes three high-pass filters that can be used to block fundamental frequencies when testing intentional radiators. The interchangeable high-pass filters block signals below their respective 1.5 GHz, 3.5 GHz and 8.25 GHz cut-off frequencies.



1 to 18 GHz Antenna mounted to Microwave Test Set

Test Chamber Microwave EMI Measurements



HP 84125 Series Test System

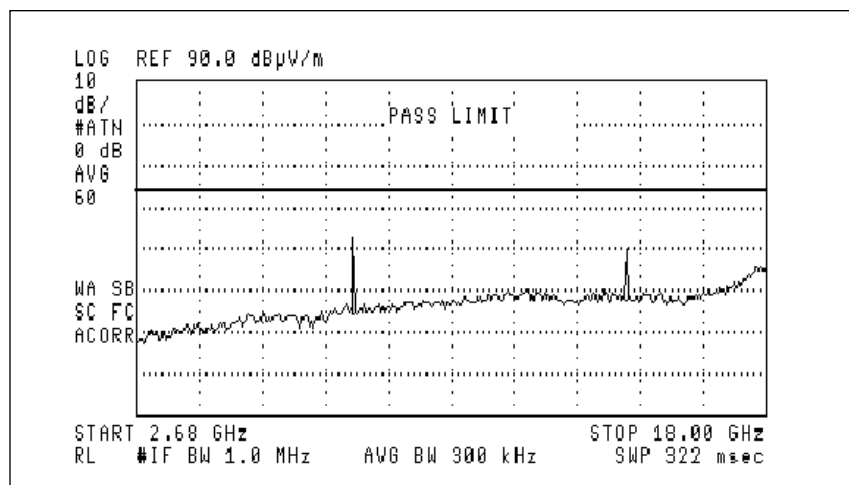
Positioning the mobile test cart and microwave test set inside the test chamber minimizes cable length and increases measurement sensitivity. Two high-gain microwave amplifiers provide additional sensitivity, which results in a low inherent system noise level. The microwave test set and horn antenna can be positioned for maximum emission levels and rotated 90 degrees to test for both horizontal or vertical signal polarizations.

The worst-case device emissions can be located by positioning the test set and antenna one meter from the test device and rotating the device on a turntable while observing signals on the EMC analyzer's display. The close-up measurement gives added sensitivity for finding emissions. When worst-case emissions are determined, the antenna can be repositioned to the test distance specified in EMI regulations, typically three meters. The device worst-case emission levels can then be compared to the regulatory

emission limits. For example, in the U.S., FCC Part 15 regulations set maximum emission limits for signals up to the tenth harmonic of the fundamental frequencies of intentional radiators. The maximum emission levels of the harmonics must be below a field strength of 54 dBuV/m at a test distance of

three meters (or 63.5 dBuV/m at a test distance of one meter).

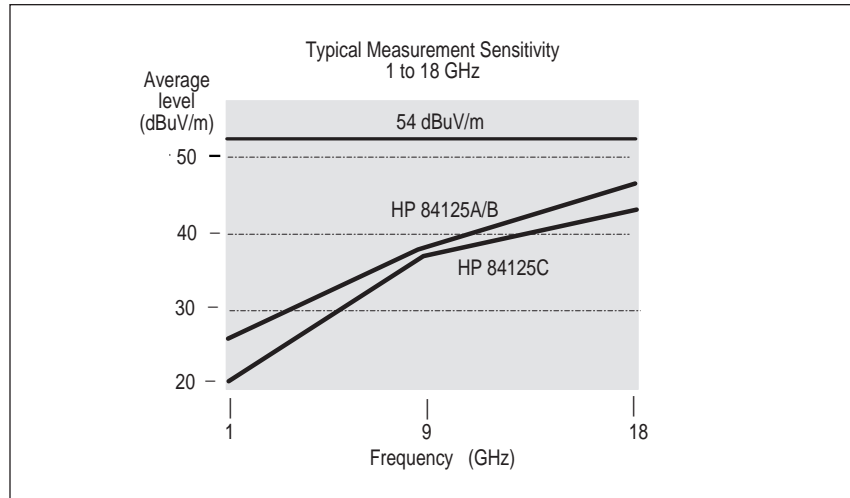
The HP 84125A microwave EMI test system display shows harmonic emission levels of an intentional radiator compared to a 64 dBuV/m field strength level at one meter.



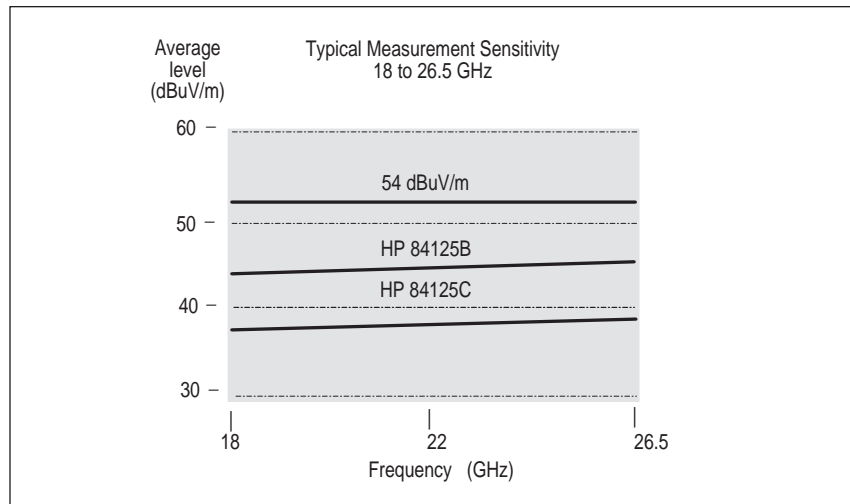
HP 84125 Series Test System

Typical System Measurement Performance

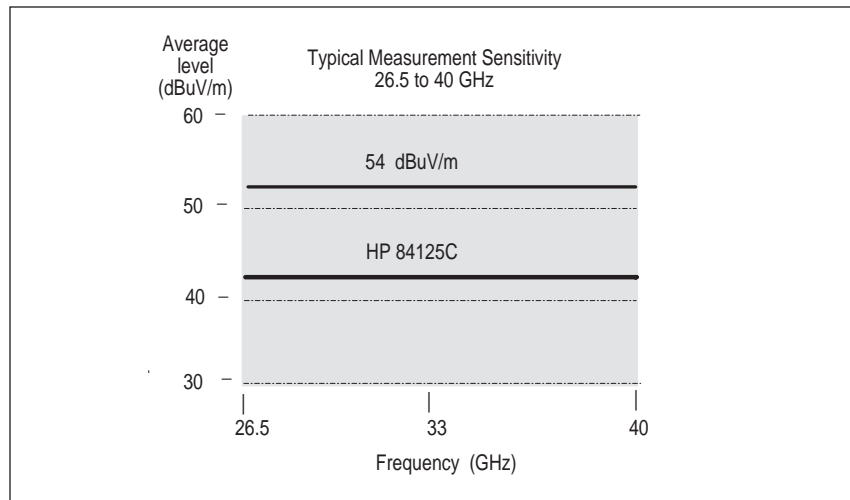
Typical HP 84125 series system measurement sensitivities are shown graphically for three bands, 1 to 18 GHz, 18 to 26.5 GHz, and 26.5 to 40 GHz. The average measurement sensitivities are measured in a 1 MHz bandwidth using typical transducer factors for each of the HP 84125 series system antennas. For reference, the FCC Part 15 three-meter limit of 54 dBuV/m is shown on each graph.



HP 84125A, B, C

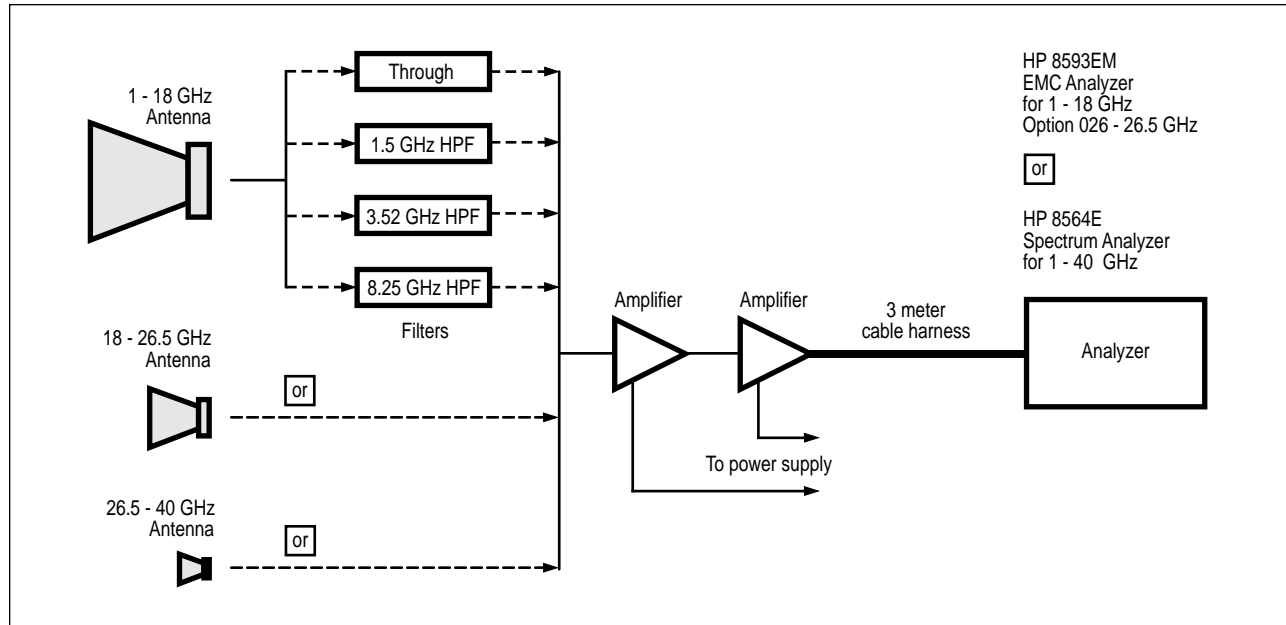


HP 84125B, C



HP 84125C

HP 84125A,B,C Systems Integration and Calibration



HP 84125 Series System Configuration

The measurement sensitivity of HP 84125 series systems is determined by the system noise level and the conversion factors

for each horn antenna. Calibration data for system amplifiers, cables, filters and antennas are stored in the analyzer's memory for automatic data correction. The EMC and spectrum analyzers provide an easy-to-use

measurement interface allowing quick recall of measurement settings and the display of corrected measurement results.

Test System Specifications

Model	Frequency Range (GHz)	Displayed Average Noise Level (dBuV) ¹		Third Order Intercept (dBuV) Characteristic
		Specified	Typical	
HP 84125A	1 to 18	8	-1	>45
HP 84125B	1 to 18	8	-1	>45
	18 to 26.5	15	5	
HP 84125C	1 to 18	6	-3	>50
	18 to 26.5	6	-1	
	26.5 to 40	9	0	

Test Set Specifications (Amplifier, filter and cable assembly)

Calibration data uncertainty	± 0.9 dB
Flatness uncertainty	± 1.7 dB Typical
Test set repeatability	± 0.7 dB ² Typical
Maximum temperature drift	± 1.5 dB ³ Typical
Input VSWR	1 to 18 GHz: 3.2:1 Typical
	18 to 40 GHz: 2.3:1 Typical

1. Specified noise levels are worst-case over respective frequency ranges and are measured in a 1 MHz bandwidth.

2. Test set repeatability includes cable flexure, amplifier aging and connection repeatability.

3. System specifications apply between the ambient temperatures of 20°C to 30°C.

HP 84125 Series System

Antenna and Filter

Horn Antenna Specifications

Frequency Range (GHz)	Antenna Factor (Typical) ¹ Range (dB/m)	Uncertainty (±dB)	VSWR (Typical)
1 to 18	24 to 47	2.0	2.8:1
18 to 26.5	40 to 41	0.5	1.4:1
26.5 to 40	43 to 44	0.5	1.4:1

Test Set Filter Specifications

Frequency Range (GHz)	Passband (GHz)	60 dB Rejection (GHz)	Passband VSWR (Typical)
1 to 18	1.5 to 18	≤ 0.95	2.1:1
1 to 18	3.52 to 18	≤ 2.5	2.1:1
1 to 18	8.25 to 18	≤ 5.9	2.3:1

EMI Accessories

Nonmetallic tripod		HP 11968C
Biconical antenna	30 to 300 MHz	HP 11966C
Log periodic antenna	300 to 1000 MHz	HP 11966D
Broadband antenna	30 to 1000 MHz	HP 11966P

¹ Antenna factors are specified at a 1 meter calibration distance.



For more information about Hewlett-Packard test and measurement products, applications, services, and for a current sales office listing, visit our web site, <http://www.hp.com/go/tmdir>. You can also contact one of the following centers and ask for a test and measurement sales representative.

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